# Energy and angular distributions of electrons transmitted through Al<sub>2</sub>O<sub>3</sub> nanocapillaries

Aleksandar R. Milosavljević<sup>1\*</sup>, J. Jureta<sup>1</sup>, Gy. Víkor<sup>1</sup>, Z. D. Pešić<sup>1</sup>, D. Šević<sup>1</sup>, S. Mátéfi-Tempfli<sup>2</sup>, M. Mátéfi-Tempfli<sup>2</sup> and B. P. Marinković<sup>1</sup>

<sup>1</sup>Laboratory for atomic collision processes, Institutute of Physics, Pregrevica 118, Belgrade, 11080, Serbia <sup>2</sup>Unité de Physico-Chimie et de Physique des Matériaux, Université Catholique de Louvain, Place Croix du Sud, 1, B-1348 Louvain-la-Neuve, Belgium

\* Present address: Synchrotron SOLEIL, 91192 Gif-sur-Yvette, France

**Girona**, 2009

Energy and angular distributions of electrons transmitted through Al2O3 nanocapillaries Summary

# Summary

- Transmission of low-energy electrons ( $\approx 2 \text{ eV} - 350 \text{ eV}$ ) through insulating  $Al_2O_3$  nanocapillaries (40, 140, 270 nm diameter; 15  $\mu$ m length) have been investigated. Measurements include energy spectra from elastic down to a few eV's and relative transmission dependence on incident electron energy, tilt angle, observation angle, incident current and time.

- The results suggest a more complex nature of low-energy electron transport through insulating nanocapillaries than proposed for positive ions.

- Further measurements with different types of capillaries are of interest!



# ITS LEIF 2nd Symposium on Ion-Insulator-Interactions

Time	Subject	Speaker / Chair Person
Wednesday 20	oth May 2009	
	SESSION 1: ION GUIDING	B.A. HUBER
14H00 - 14H30	Opening - Introduction	Y. Yamazaki,
		Riken, JP
14h30 - 15h00	Dynamics of insulator nano-capillary charge up	R. Schuch, Stockholm Univ., SE
15h00 - 15h30	Dynamic properties of ion guiding through nanocapillaries in an insulating	<i>E. Bodewits,</i>
	polymer	KVI Groningen, NL
15h30 - 16h00	Coffee Break	
	SESSION 2: ION GUIDING	J. TANIS
16h00 - 16h30	Guiding of slow HCI beams through glass-made optics	T. Ikeda, Riken, JP
16h30 - 17h00	Imaging the auto-organised charging dynamics of glass capillaries by ion	A. Cassimi,
	beams	CEA-CIMAP, Caen, FR
17h00 - 17h30	The guiding in flat capillaries	G. Pokhil, Moscow State Univ., RU
17h30 - 18h00	Simulations of charged-particle transport through capillary targets	C. Lemell,
		ITP, TUW, Vienna, AT
19h30	Dinner	
Thursday 21st	May 2009	
	SESSION 3: ION-SURFACE INTERACTIONS	F. AUMAYR
9H00 - 9H30	Swift heavy ion collisions with surfaces under grazing incidence	H. Lebius,
	New york of the barrier barrier barrier barrier barrier barrier and the second	CEA-CIMAP, Caen, FR
9h30 - 10h00	Nanostructures induced by highly charged ions on insulating surfaces	René Heller, FZD Dresden, DE
10h00 - 10h30	Coffee Break	
	SESSION 4: ION-SURFACE INTERACTIONS	R. SCHUCH
10h30 - 11h00	SESSION 4: ION-SURFACE INTERACTIONS Sputtering and surface modification of insulators: charge effect	R. SCHUCH B. Ban d'Etat
	Sputtering and surface modification of insulators: charge effect	B. Ban d'Etat CEA-CIMAP, Caen, FR
	Sputtering and surface modification of insulators: charge effect Potential energy - induced nanostructuring of insulator surfaces by impact	B. Ban d'Etat CEA-CIMAP, Caen, FR F. Aumayr,
11h00 - 11h30	Sputtering and surface modification of insulators: charge effect Potential energy - induced nanostructuring of insulator surfaces by impact of slow, very highly charged ions	B. Ban d'Etat CEA-CIMAP, Caen, FR F. Aumayr, IAP, TUW, Vienna, AT
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# **ITSLEIF NEWSLETTER**

Ion Technology and Spectroscopy at Low Energy Ion Beam Facilities a European Integrated Infrastructure Initiative (I3)





# The 4<sup>th</sup> Annual Meeting – a Great Success!



From 15th to 22nd of May 2009 the 4th Annual Meeting was organised in Platja d'Aro in Spain counting about 100 participants. For the first time the meeting lasted for one week, including the 2<sup>nd</sup> International Symposium on Ion Insulator Interactions (S3I, see further below). During the first day, the different ITS LEIF Committees assessed the activities in their respective fields. In particular, the deliverables and the financial situation have been discussed and reviewed in view of the 6-months extension of the contract. During the following days, the users presented their projects in the framework of the Transnational Access Activity and the Proposal Selection Panel discussed the beam time attribution which was ratified by the Executive Committee. The contributions, presented during the foresight stud ies from nearby fields, have been appreciated very much. They covered a large spectrum of science, ranging from Cosmo-climatology (H. Svensmark, DNSC, DK), the Irradiation of small organic molecules and clusters (E. Suraud, IRSAMC, FR), Charge instabilities of microdroplets (E. Giglio, CIMAP, FR) to Power dissipation in cold microplasma jets (T. Gans, QUB, UK) and Graphene and Boron Nitride single layer templates (T. Greber, U. Zürich, CH). At half-time of the meeting, a half-day excursion to the old town of Girona and the Museum of Dali allowed to discuss physics from another point of view and in a different surrounding. Although no specific summer school was integrated in the programme, the participation of young researchers with about 40% was again very encouraging. A fifth Annual Meeting is planned to be held in June 2010.

Bernd A. Huber, ITS LEIF Coordinator



Jan. 24 - 29, 2010 Universitätszentrum Obergurgl, Austria



This international sym-

posium is one in a continuing biennial series of conferences (the last one was held in 2008 in Les Diablerets, Switzerland) which seeks to promote the growth of scientific knowledge and effective exchange of information among scientists in the field of atomic, molecular, and surface physics and with a major focus on nano particles and biomolecules. The symposium deals in particular with collisional interactions involving different types of collision partners, i.e. electrons, photons, molecules, nano particles, and surfaces. A special emphasis of this conference will be to provide room for discussion between academics and industry by a proper choice of lecturers. http://www.uibk.ac.at/ionen-angewandtephysik/tagungen/sasp10/

#### **Clustertreffen 2009**

4-9 Oct. 2009, Herzogenhorn, Schwarzwald, Germany

The "Clustertreffen" is an informal workshop about cluster physics and related fields. This year, the meeting will take place from the 4th to the 9th of October, 2009 in the federal centre for competitive sports at

Herzogenhorm in the Black Forest.

Contact: clustertreffen@physik.uni-freiburg.de





## Highest German Award for Prof. Dr. H. Schmidt-Böcking

In recognition of his outstanding scientific achievements as an experimental physicist - including the development of the COLTRIMS and his contributions to Reaction Microscope technology - Prof. Dr. H. Schmidt-Böcking has received the most prominent German award, the "Verdienstkreuz 1. Klasse des Verdi-

enstordens der Bundesrepublik Deutschland". Ceremoniously presented by the President of the Federal Republic of Germany, Horst Köhler, Horst Schmidt-Böcking was honoured not only for his far-reaching contributions to the science of ultra-fast correlated electronic motion in atoms and molecules, but also for his accomplishments as a Professor, teacher and leader of a research group at the University of Frankfurt. Internationally recognized on the highest level, e.g. as the first non-American recipient of the prestigious Davisson-

Germer Award of the American Physical Society, many of his students have developed to take on leading positions in the field worldwide.

Scientifically, the aforementioned instruments have revolutionized our understanding of many-body quantum dynamics in atomic and molecular physics by enabling fewparticle coincidences through projection technologies. They are well-known and operated in many laboratories worldwide, for the investigation of atomic and molecular collisions, at synchrotrons, free electron lasers and are considered to be a key technology in the emerging field of "atto science", the exploration of ultra-fast electronic and nuclear motion on time-scales below  $10^{-15}$  s.

We all know Horst as an enthusiastic scientist and enlightening teacher usually with many more visions and ingenious ideas than his group or likely the whole Institute could ever realize! Those who had the pleasure to work with him appreciate his always optimistic attitude, his charming and warm personality, his never ending energy attacking new obstacles, his fresh and unconventional view on the enigma of correlated and entangled electron motion, "flying fishes" and much more. Thanks, Horst and congratulations!





H. Schmidt-Böcking, Head of the ITS LEIF Scientific Council.

News

## The 2<sup>nd</sup> Symposium on Ion Insulator Interactions S3I



Charged particle beam - insulator interactions were avoided so far, as they mostly showed un-reproducable results and macroscopic chargeup effects. Recently, through the ability to produce and analyze nanostructured materials, such as nano-capillaries, in-situ atomic force microscopes, and improved beam handling, a new access to ion-insulator interaction was opened.

Because of this being an intense research and development activity in ITS LEIF an International Symposium entitled "Ion Insulator Interactions (S3I)" was held on the 20<sup>th</sup> and 21<sup>st</sup> of May, after the 4<sup>th</sup> Annual ITS LEIF Meeting. It was the second meeting of this kind with the first one held in Japan, Sept. 2008. The field is rapidly developing into different branches and showing exciting spring-offs. The issues of strongest concerns, that were discussed at the meeting, are the guiding (enhanced transport by electrical charge up) of charged particles in capillaries, with various geometrical properties, cylindrical, tapered, romboedric capillaries from a few nanometers to mm diameter, and parallel glass plates, as well as different insolating materials. Particle beams of charged ions, electrons, myons are transmitted and partly focused to micrometer spots. Bio-medical applications are started. Very closely connected to that, particularly to the parallel glass plates - is charging of insulator surfaces - with instabilities, discharges, showing oscillations in transmission and strong non linear effects. These were observed and theoretically postulated. Another highlight was the dynamics of charge up, seen in oscillations of the centroid of transmitted intensity by several groups which has now been proven by theory as well. A bit more contradictory was the transmission of electrons through nano-structures. Is it really guiding or scattering?

In ion-beam induced modifications of insulating surfaces, reports on blisters and craters were given, with a control of size and positioning within reach.

The presentations given will become available on the ITS LEIF website soon. The discussion was very lively and culminated in a quest to establish criteria and definitions of "guiding", "guiding power", "charge-up properties", "fresh or treated surfaces", "memory effects", ... A next meeting has already been envisaged.

Reinhold Schuch, Stockholm University

# Instrumentation & Experimental Techniques

## High-Resolution Mass Spectrometry of Femtosecond Laser Produced Ions

Short pulse, intense IR lasers have a number of features which are desirable in mass spectrometry. Ionisation by a femtosecond  $(10^{-15} s)$  laser pulse is efficient and sensitive, producing an ion bunch that is well defined in space and time.

At Queen's University Belfast, we use a novel linear electrostatic trap (Fig. 1) to analyse the masses of the ions produced via femtosecond laser induced ionisation. Once trapped, these ions oscillate on stable trajectories with frequencies inversely proportional to the square root of their mass and are detected non-destructively by a pick-up ring. A Fourier transform of the time dependent signal yields mass spectra which can be of high



resolution (Fig. 2). Our results demonstrate

that the laser



Fig 1: KEIRA (Kilovolt Electrostatic Ion Reflection Analyser)

produced ions have a very small energy spread and spatial extent which means that the ions remain bunched for long periods in the trap. At present the mass resolution is limited by the background gas pressure of a few 10<sup>-7</sup> mbar. The trapping conditions in our apparatus are mass-independent and thus this technique promises useful application to larger biomolecular systems in future studies.

Contact: Jason Greenwood (j.greenwood@qub.ac.uk), Orla Kelly (okelly04@qub.ac.uk), Queen's University Belfast, Northern Ireland.

Fig 2: Separation of xenon isotopes in frequency space, achieving a resolution of  $m/\Delta m = 10^4$ .

2